

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination MA ET AL.	
		Examiner Jonathan Liou	Art Unit 2663	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-2002/0034213	03-2002	Wang et al.	375/132
B	US-2002/0122383	09-2002	Wu et al.	370/210
C	US-2003/0016621	01-2003	Li, Ye	370/203
D	US-6,298,035	10-2001	Heiskala, Juha	370/206
E	US-6,359,938	03-2002	Keevill et al.	375/316
F	US-2002/0080887	06-2002	Jeong et al.	375/295
G	US-5,867,478	02-1999	Baum et al.	370/203
H	US-2002/0003774	01-2002	Wang et al.	370/208
I	US-2002/0181390	12-2002	Mody et al.	370/208
J	US-2002/0144294	10-2002	Rabinowitz et al.	725/139
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	
V	
W	
X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.